

**Notice of References Cited**

Application/Control No.

10/766,246

Applicant(s)/Patent Under  
Reexamination  
NIELSEN ET AL.

Examiner

HIEU HOANG

Art Unit

2452

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*	B	US-2003/0182425	09-2003	Kurakake, Shoji	709/226
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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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